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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/618,602	07/15/2003	Naoki Matsumoto	010986.52602US	5343	
23911 CROWELL & I	7590 08/07/200 MORING LLP	8	EXAMINER		
INTELLECTUAL PROPERTY GROUP P.O. BOX 14300			ALEJANDRO MULERO, LUZ L		
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,			1792		
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)	
	10/618,602	MATSUMOTO ET AL.	
Office Action Summary	Examiner	Art Unit	
	Luz L. Alejandro	1792	
The MAILING DATE of this communicati Period for Reply	on appears on the cover sheet	vith the correspondence address	
A SHORTENED STATUTORY PERIOD FOR WHICHEVER IS LONGER, FROM THE MAIL! - Extensions of time may be available under the provisions of 37 after SIX (6) MONTHS from the mailing date of this communica - If NO period for reply is specified above, the maximum statutor - Failure to reply within the set or extended period for reply will, be any reply received by the Office later than three months after the earned patent term adjustment. See 37 CFR 1.704(b).	NG DATE OF THIS COMMUN CFR 1.136(a). In no event, however, may a tition. y period will apply and will expire SIX (6) MO by statute, cause the application to become	ICATION. I reply be timely filed INTHS from the mailing date of this communication ABANDONED (35 U.S.C. § 133).	
Status			
1) Responsive to communication(s) filed or	☐ This action is non-final. allowance except for formal ma		3
Disposition of Claims			
4) ☐ Claim(s) 1-13 and 16-26 is/are pending 4a) Of the above claim(s) 1-12,18,20 and 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 13,16,17,19,21-23,25 and 26 is 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction Application Papers 9) ☐ The specification is objected to by the Ex	d 24 is/are withdrawn from constant is/are rejected. and/or election requirement.	ideration.	
10) The drawing(s) filed on is/are: a) Applicant may not request that any objection Replacement drawing sheet(s) including the 11) The oath or declaration is objected to by	accepted or b) objected to the drawing(s) be held in abeyon correction is required if the drawing	ance. See 37 CFR 1.85(a). g(s) is objected to. See 37 CFR 1.121(d	d).
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a claim for f a) All b) Some * c) None of: 1. Certified copies of the priority doc 2. Certified copies of the priority doc 3. Copies of the certified copies of the application from the International * See the attached detailed Office action fo	uments have been received. uments have been received in the priority documents have bee Bureau (PCT Rule 17.2(a)).	Application No n received in this National Stage	
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-93) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 0308.	948) Paper No	Summary (PTO-413) (s)/Mail Date Informal Patent Application 	

DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 13, 16, 19, 23, and 25-26 are rejected under 35 U.S.C. 103(a) as being unpatentable over Taguchi et al., U.S. Patent 6,469,448 in view of Baldwin, Jr. et al., U.S. Patent 6,280,563, Okabe et al., JP 2000-355771, Glukhoy, US 2003/0168172, and Ueda et al., US 2003/0183169.

Taguchi et al. shows the invention substantially as claimed including a plasma processing apparatus for supplying radio-frequency power into a process chamber so as to generate plasma, to thereby treat an object to be processed with the plasma; wherein the process chamber has a top which is disposed opposite to the object to be

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processed through the medium of a region for generating the plasma; wherein a plurality of metal-based radio-frequency antennas 9 are disposed in the process chamber, wherein the process chamber has a chamber wall having at least one antenna so that the antenna penetrates the chamber wall into the inside of the process chamber (see figs. 5 and 12 and their descriptions).

Taguchi et al. does not expressly disclose where the top plate comprises a metal or silicon based material. Baldwin, Jr. et al. discloses a top plate 44 with a potential applied which is made of a metal (see fig. 1 and its description). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. so as to have the top plate composed of a metal because, as disclosed by Baldwin, Jr. et al., such a material is suitable for having RF potential applied.

Taguchi and Baldwin, Jr. et al. are applied as above but do not expressly disclose wherein the antenna provides linear lines, electric current flows in each of the antenna in one direction so that the direction of electric currents in plural antennas are the same and induction electric fields due to the electric currents in the plural antennas are strengthened by each other on a basis of interactions therebetween. Okabe et al. discloses wherein the antenna provides linear lines (4,5) so that the direction of electric currents in plural antennas are the same, induction electric fields due to the electric currents in the plural antennas are strengthened by each other on a basis of interactions therebetween and the adjacent antennas are in parallel with each other on the same plane which is parallel to the object to be processed (see abstract and Figures). In view

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of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al. so as to include the claimed antenna configuration as disclosed by Okabe et al. because using such an antenna arrangement a more uniform plasma over a wider area is possible.

Taguchi et al., Baldwin, Jr. et al., and Okabe et al. are applied as above but do not expressly disclose that the antenna disposed in the process chamber is covered with an insulating material so that the radio-frequency antenna does not directly contact the plasma, wherein an insulating fluid is circulated between the antenna and the insulating material, and wherein the process chamber has a second chamber wall opposed to the first chamber wall, and each antenna penetrates the first chamber wall and the second chamber wall. Glukhov discloses that the antenna disposed in the process chamber is covered with an insulating material 64 so that the radio-frequency antenna does not directly contact the plasma, wherein an insulating fluid is circulated between the antenna and the insulating material using tubes 82 (see paragraph 0035-0036), and wherein the process chamber has a second chamber wall opposed to the first chamber wall, and each antenna penetrates the first chamber wall and the second chamber wall. In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al. and Okabe et al. in order to cover the antenna with an insulating material, circulate an insulating fluid between the antenna and insulating material, and have an antenna penetrating opposing sidewalls because such a structure Art Unit: 1792

will protect the antenna as well as control the temperature of the antenna to avoid damage and be suitable for generating an inductively coupled plasma.

Taguchi et al., Baldwin, Jr. et al., Okabe et al., and Glukhoy are applied as above but do not expressly disclose wherein said radio-frequency power is distributed by a distributor so that the radio-frequency power can be supplied into the process chamber from said plurality of antennas. Ueda et al. discloses wherein said radio-frequency power is distributed by a distributor (14,15) so that the radio-frequency power can be supplied into the process chamber from said plurality of antennas (see fig. 3 and its description). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al., Okabe et al., and Glukhoy so as to include the distributor of Ueda et al. because in such a way RF power can be effectively applied to the antennas without a need for separate RF supplies.

Concerning claim 16, it would have been obvious to one of ordinary skill in the art at the time the invention was made to determine through routine experimentation the optimum length of the antenna based upon a variety of factors including the desired area of the plasma distribution and such limitation would not lend patentability to the instant application absent a showing of unexpected results.

Regarding claim 23, note that the apparatus as shown in Taguchi et al. includes a susceptor 6 for supporting the object to be processed in the process chamber, and a bias 7 is applicable to the susceptor.

Concerning claim 25, note that in the apparatus of Taguchi et al. modified by Baldwin, Jr. et al., Okabe et al., Glukhoy and Ueda et al., the electric fields are capable of being strengthened by one another.

Claim 17 is rejected under 35 U.S.C. 103(a) as being unpatentable over Taguchi et al., U.S. Patent 6,469,448 in view of Baldwin, Jr. et al., U.S. Patent 6,280,563, Okabe et al., JP 2000-355771, Glukhoy, US 2003/0168172, and Ueda et al., US 2003/0183169, as applied to claims 13, 16, 19, 23, and 25-26 above, and further in view of Holland et al., U.S. Patent 5,975,013 or Takagi et al., US 2004/0020432.

Taguchi et al., Baldwin, Jr. et al., Okabe et al., Glukoy, and Ueda et al. are applied as above but do not expressly disclose wherein the thickness or diameter of the radio frequency antenna disposed in the process chamber is changed along with the propagation direction of the radio frequency power. Holland et al. discloses varying the thickness or diameter of a radio frequency antenna (see fig. 11 and its description), as does Takagi et al. (see fig. 2 and its description). In view of these disclosures, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al., Okabe et al., Glukhoy, and Ueda et al. so as to vary the thickness and/or the diameter of the coil as claimed because in such a way a uniform plasma density can be achieved.

Claims 21-22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Taguchi et al., U.S. Patent 6,469,448 in view of Baldwin, Jr. et al., U.S. Patent

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6,280,563, Okabe et al., JP 2000-355771, Glukhoy, US 2003/0168172 and Ueda et al., US 2003/0183169, as applied to claims 13, 16, 19, 23, and 25-26 above, and further in view of Grimbergen et al., U.S. Patent 6,390,019.

Taguchi et al., Baldwin, Jr. et al., Okabe et al., Glukhoy, and Ueda et al. are applied as above but do not expressly disclose wherein a measuring device is disposed in at least one position of the top plate so as to monitor the state of the generated plasma and the top plate has a plurality of apertures for passing a gas to be supplied to the processing chamber. Grimbergen et al. discloses a measuring device 25 which is disposed in the top of the chamber so as to monitor the state of the generated plasma (see fig. 1 and its description), and a top plate which has a plurality of apertures for passing a gas to be supplied to the process chamber (see, for example, figs. 2 and 3a and their descriptions). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al., Okabe et al., Glukhoy, and Ueda et al. so as to have the measuring device and apertures as suggested by Grimbergen et al. because having the measuring device and apertures in the top plate allows for accurate measurements and uniform distribution of the gas across the workpiece.

Response to Arguments

Applicant's arguments with respect to claims 13, 16-17, 19, 21-23, and 25-26 have been considered but are moot in view of the new ground(s) of rejection.

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Conclusion

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Luz L. Alejandro whose telephone number is 571-272-1430. The examiner can normally be reached on Monday to Thursday from 7:30 to 6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Parviz Hassanzadeh can be reached on 571-272-1435. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Luz L. Alejandro/ Primary Examiner, Art Unit 1792

August 3, 2008